

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination ITABASHI ET AL.	
		Examiner Edna Wong <i>CW 9/10/03</i>	Art Unit 1753	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-2002/0064592	05-2002	Datta et al.	427/98
B	US-			
C	US-			
D	US-			
E	US-			
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N	JP 2000144438 A	05-2000	Japan	SENDAI et al.	C23C 18/31
O	JP 07268638 A	10-1995	Japan	ITABASHI et al.	C23C 18/31
P					
Q					
R					
S					
T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.